Docket No.: H6808.0024/P024

Art Unit: N/A

(PATENT)

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Pa	atent Ap	plication	of:
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Hiroshi Miyai, et al.

Application No.: Not Yet Assigned

Filed: Concurrently Herewith

For: EXAMINATION METHOD AND Examiner: Not Yet Assigned

APPARATUS USING ELECTRON BEAM

## **CLAIM FOR PRIORITY**

MS Patent Application Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

Applicant hereby claims priority under 35 U.S.C. 119 based on the following prior foreign application filed in the following foreign country on the date indicated:

CountryApplication No.DateJapan2002-280142September 26, 2002



In support of this claim, a certified copy of the said original foreign application will be filed shortly.

Dated: September 25, 2003

Respectfully submitted,

Mark J. Thronson

Registration No.: 33,082

DICKSTEIN SHAPIRO MORIN &

OSHINSKY LLP

2101 L Street NW

Washington, DC 20037-1526

(202) 785-9700

Attorney for Applicant